

**Notice of References Cited**

Application/Control No.

10/532,097

Applicant(s)/Patent Under  
Reexamination  
WAKUI ET AL.

Examiner

In Suk Bullock

Art Unit

1797

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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